

# PC401

## Compact, Surface Mount Type OPIC Photocoupler

### ■ Features

1. Mini-flat package
2. "High" output during light emission
3. Isolation voltage between input and output  
( $V_{iso} : 3\,750V_{rms}$ )
4. TTL and LSTTL compatible output
5. Recognized by UL(No.64380)

### ■ Applications

1. Hybrid substrate which requires high density mounting
2. Personal computers, office computers and peripheral equipment
3. Electronic musical instruments

### ■ Package Specifications

Model No.	Package specifications	Diameter of reel	Tape width
PC401	Taping package (Net : 3 000pcs.)	370mm	12mm
PC401T	Taping package (Net : 750pcs.)	178mm	12mm
PC401Z	Sleeve package (Net : 100pcs.)	-	-

### ■ Absolute Maximum Ratings

( $T_a = 25^\circ C$ )

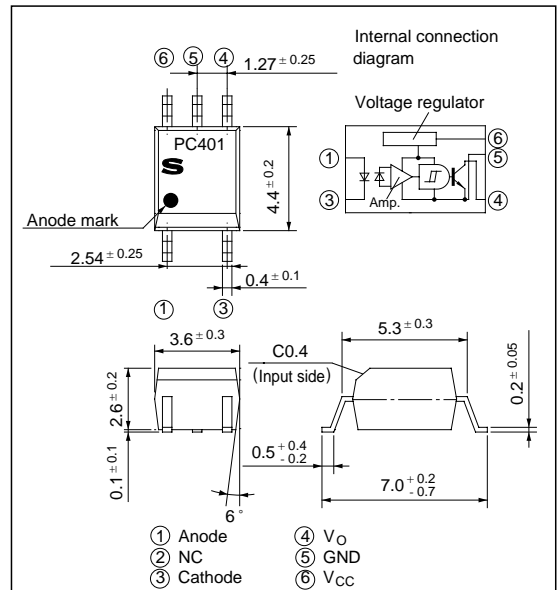
Parameter		Symbol	Rating	Unit
Input	Forward current	$I_F$	50	mA
	Reverse voltage	$V_R$	6	V
	Power dissipation	P	70	mW
Output	Supply voltage	$V_{CC}$	16	V
	High level output voltage	$V_{OH}$	16	V
	Low level output current	$I_{OL}$	50	mA
	Power dissipation	$P_O$	130	mW
Total power dissipation		$P_{tot}$	150	mW
*1	Isolation voltage	$V_{iso}$	3 750	$V_{rms}$
Operating temperature		$T_{opr}$	- 25 to + 85	$^\circ C$
Storage temperature		$T_{stg}$	- 40 to + 125	$^\circ C$
*2	Soldering temperature	$T_{sol}$	260	$^\circ C$

\*1 AC for 1 minute, 40 to 60% RH

\*2 For 10 seconds

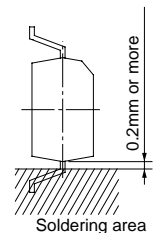
### ■ Outline Dimensions

(Unit : mm)



\* "OPIC" (Optical IC) is a trademark of the SHARP Corporation.

An OPIC consists of a light-detecting element and signal-processing circuit integrated onto a single chip.



■ Electro-optical Characteristics

( $T_a = 0$  to  $+ 70^\circ\text{C}$  unless otherwise specified.)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Input	Forward voltage	$V_F$	$I_F = 4\text{mA}$	-	1.1	1.4	V	
			$I_F = 0.3\text{mA}$	0.7	1.0	-		
	Reverse current	$I_R$	$T_a = 25^\circ\text{C}, V_R = 3\text{V}$	-	-	10	$\mu\text{A}$	
	Terminal capacitance	$C_t$	$T_a = 25^\circ\text{C}, V = 0, f = 1\text{kHz}$	-	30	250	pF	
Output	Operating supply voltage	$V_{CC}$		3	-	15	V	
	Low level output voltage	$V_{OL}$	$I_F = 0, V_{CC} = 5\text{V}, I_{OL} = 16\text{mA}$	-	0.2	0.4	V	
	High level output current	$I_{OH}$	$I_F = 4\text{mA}, V_{CC} = V_O = 15\text{V}$	-	-	100	$\mu\text{A}$	
	Low level supply current	$I_{CCL}$	$I_F = 0, V_{CC} = 5\text{V}$	-	2.5	5.0	mA	
	High level supply current	$I_{CCH}$	$I_F = 4\text{mA}, V_{CC} = 5\text{V}$	-	2.7	5.5	mA	
Transfer characteristics	*3 "H→L" threshold input current	$I_{FHL}$	$T_a = 25^\circ\text{C}, V_{CC} = 5\text{V}, R_L = 280\Omega$	0.4	0.8	-	mA	
			$V_{CC} = 5\text{V}, R_L = 280\Omega$	0.3	-	-		
	*4 "L→H" threshold input current	$I_{FLH}$	$T_a = 25^\circ\text{C}, V_{CC} = 5\text{V}, R_L = 280\Omega$	-	1.1	2.0	mA	
			$V_{CC} = 5\text{V}, R_L = 280\Omega$	-	-	4.0		
	*5 Hysteresis		$I_{FHL} / I_{FLH}$	$V_{CC} = 5\text{V}, R_L = 280\Omega$	0.5	0.7	0.9	
	Isolation resistance		$R_{ISO}$	$T_a = 25^\circ\text{C}, \text{DC} 500\text{V}, 40$ to $60\%$ RH	$5 \times 10^{10}$	$10^{11}$	-	$\Omega$
*6 Response time	"H→L" propagation delay time	$t_{PHL}$	$T_a = 25^\circ\text{C}, V_{CC} = 5\text{V}$ $R_L = 280\Omega, I_F = 4\text{mA}$	-	2	6	$\mu\text{s}$	
	"L→H" propagation delay time	$t_{PLH}$		-	1	3		
	Fall time	$t_f$		-	0.05	0.5		
	Rise time	$t_r$		-	0.1	0.5		

\*3  $I_{FHL}$  represents forward current when output gese from high to low.

\*4  $I_{FLH}$  represents forward current when output goes from low to high.

\*5 Hysteresis stands for  $I_{FHL} / I_{FLH}$ .

\*6 Test circuit for response time is shown below.

Test Circuit for Response Time

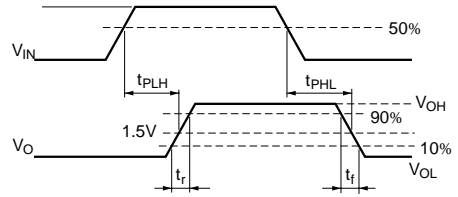
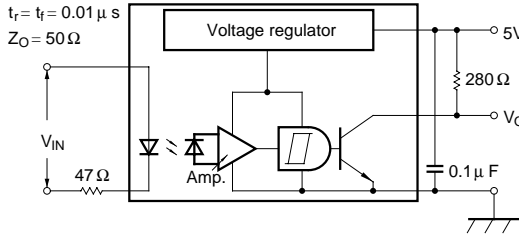


Fig. 1 Forward Current vs. Ambient Temperature

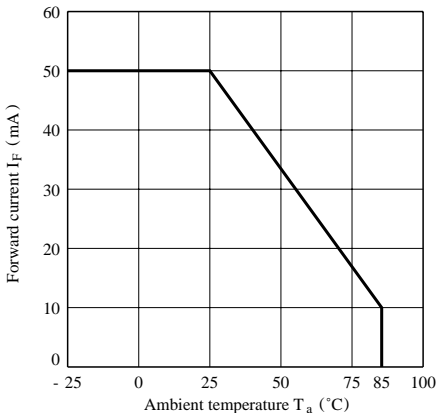
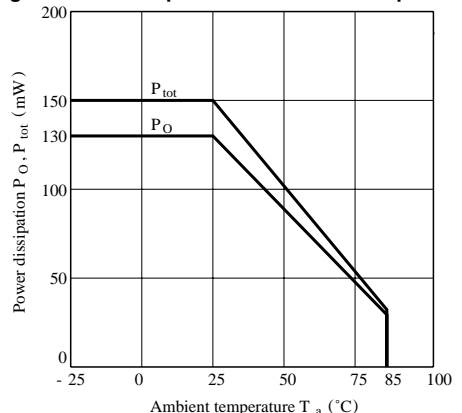
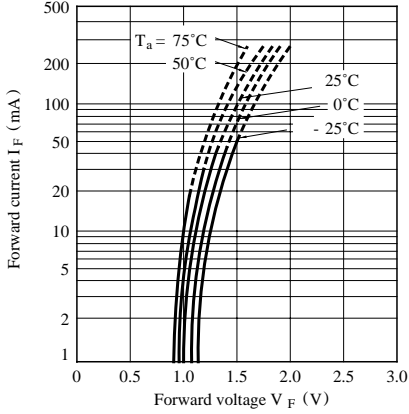


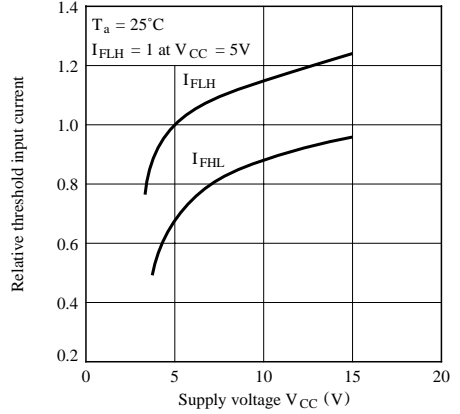
Fig. 2 Power Dissipation vs. Ambient Temperature



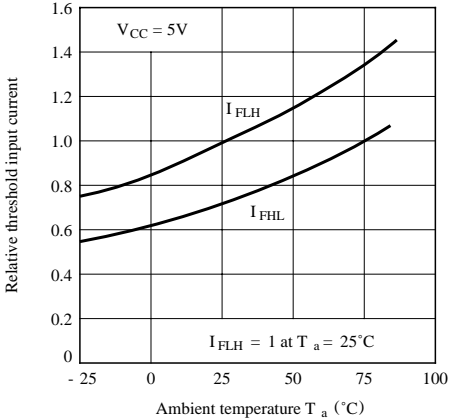
**Fig. 3 Forward Current vs. Forward Voltage**



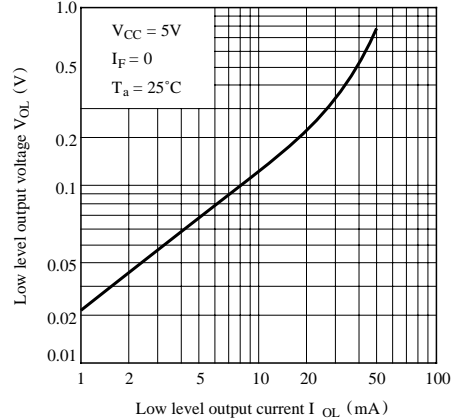
**Fig. 4 Relative Threshold Input Current vs. Supply Voltage**



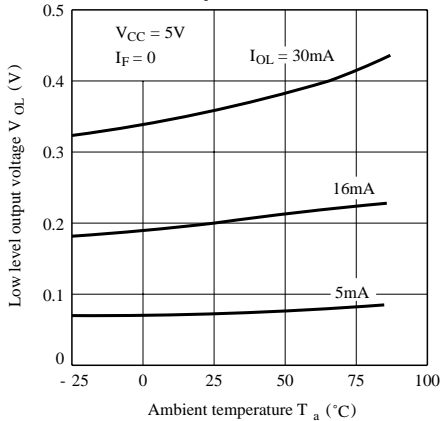
**Fig. 5 Relative Threshold Input Current vs. Ambient Temperature**



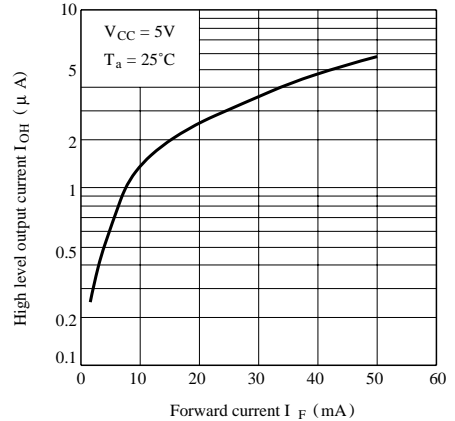
**Fig. 6 Low Level Output Voltage vs. Low Level Output Current**



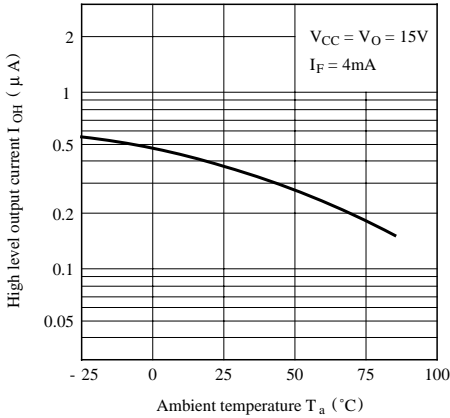
**Fig. 7 Low Level Output Voltage vs. Ambient Temperature**



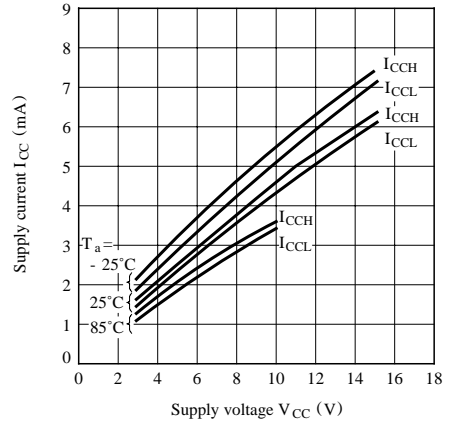
**Fig. 8 High Level Output Current vs. Forward Current**



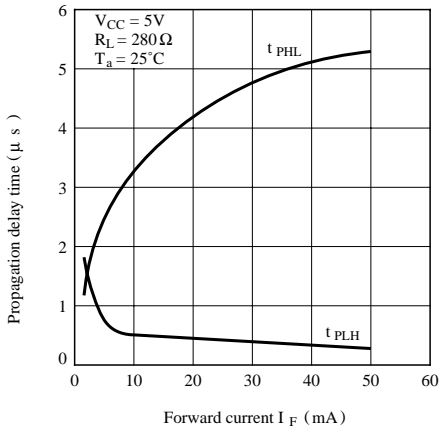
**Fig. 9 High Level Output Current vs. Ambient Temperature**



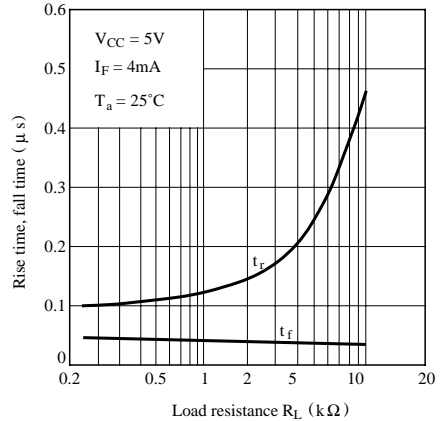
**Fig.10 Supply Current vs. Supply Voltage**



**Fig.11 Propagation Delay Time vs. Forward Current**



**Fig.12 Rise Time, Fall Time vs. Load Resistance**



**■ Preautions for Use**

- (1) It is recommended that a by-pass capacitor of more than 0.01μ F is added between V<sub>cc</sub> and GND near the device in order to stabilize power supply line.
- (2) Handle this product the same as with other integrated circuits against static electricity.
- (3) As for other general cautions, refer to the chapter “Preautions for Use”

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